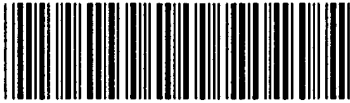


Search Notes

Application/Control No.

10/809,725

Examiner

Rene Towa

Applicant(s)/Patent under
Reexamination

CHAN, FRANK A.

Art Unit

3736

SEARCHED

Class	Subclass	Date	Examiner
600	573	10/1/2006	RTT
600	576	10/1/2006	RTT
600	583	10/1/2006	RTT
606	181	10/1/2006	RTT
606	182	10/1/2006	RTT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
SEE SEARCH HISTORY	10/1/2006	RTT